

Search Notes

Application/Control No.

10/507,339

Examiner

Anthony Weier

Applicant(s)/Patent under
Reexamination

HIRON, SHELLEY

Art Unit

1761

SEARCHED

Class	Subclass	Date	Examiner
426	634, 656		
530	370, 374	9/19/2005	AW

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Search	9/19/2005	